

## P-Channel Enhancement Mode MOSFET

### GENERAL DESCRIPTION

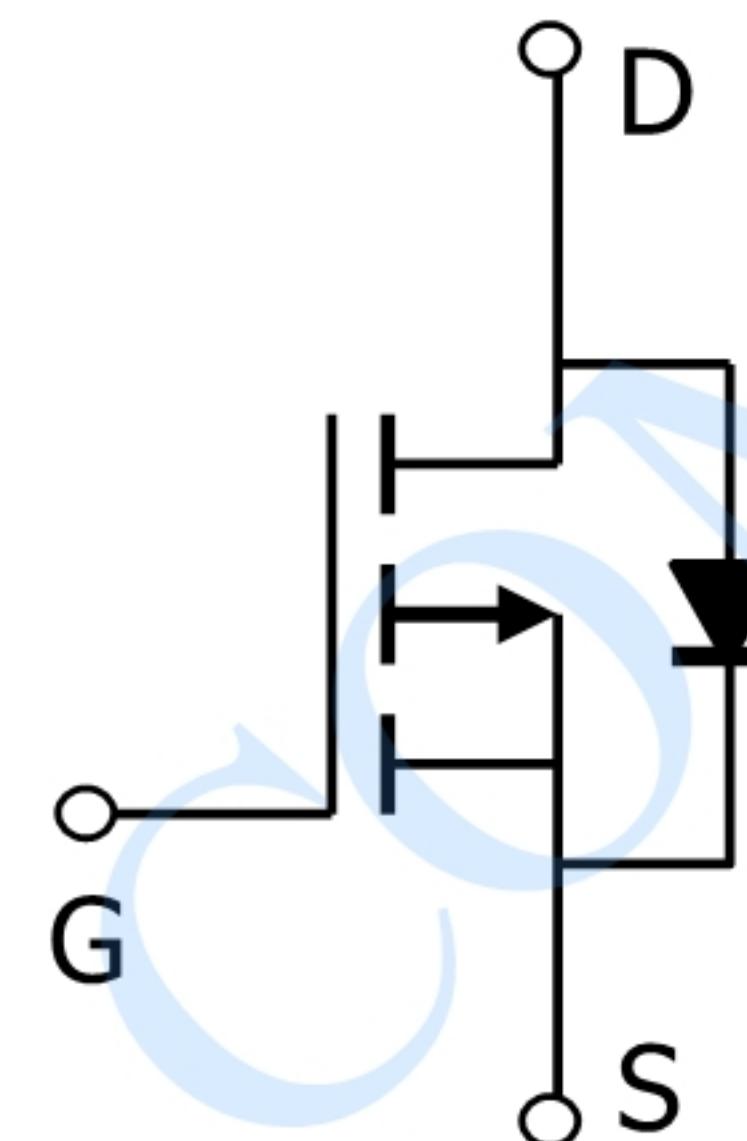
The PW2309 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### FEATURES

VDS = -60V, ID = -3A

RDS(ON) < 180mΩ @ VGS=-10V

Available in a 3-Pin SOT23-3 Package

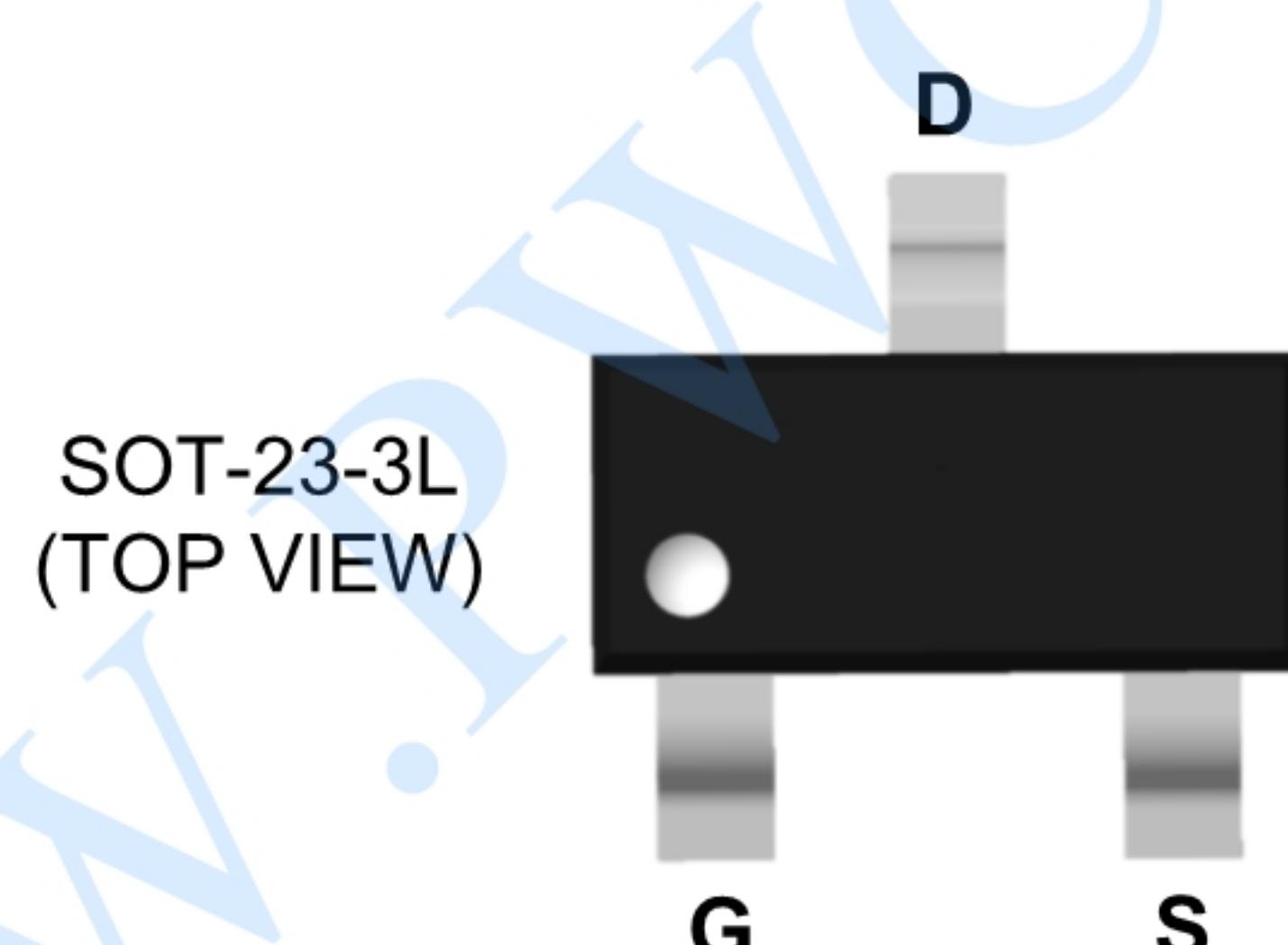


### Application

Battery protection

Load switch

Uninterruptible power suppl



### Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	-60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current, VGS @ -10V (NOTE1)	I <sub>D</sub> @TA=25°C	-3.3	A
	I <sub>D</sub> @TA=70°C	-1.4	A
Pulsed Drain Current (NOTE2)	I <sub>DM</sub>	-7	A
Total Power Dissipation (NOTE3)	P <sub>D</sub> @TA=25°C	1	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 To 150	°C
Thermal Resistance Junction-Ambient (NOTE1)	R <sub>θJA</sub>	125	°C/W
Thermal Resistance Junction-Case (NOTE1)	R <sub>θJC</sub>	80	°C/W

Note 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%

Note 3.The power dissipation is limited by 150°C junction temperature



## ELECTRICAL CHARACTERISTICS

(TA = 25°C, unless otherwise noted.)

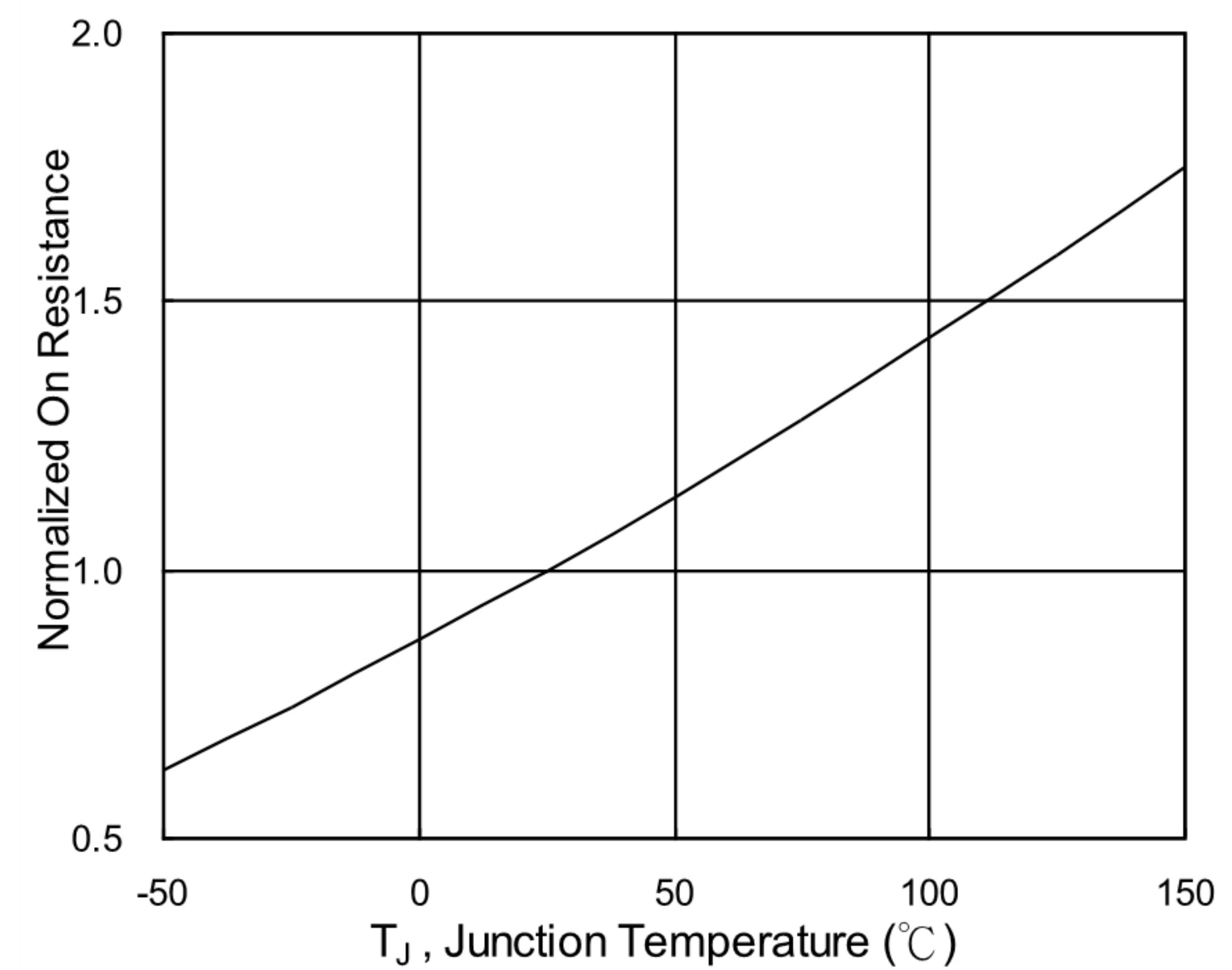
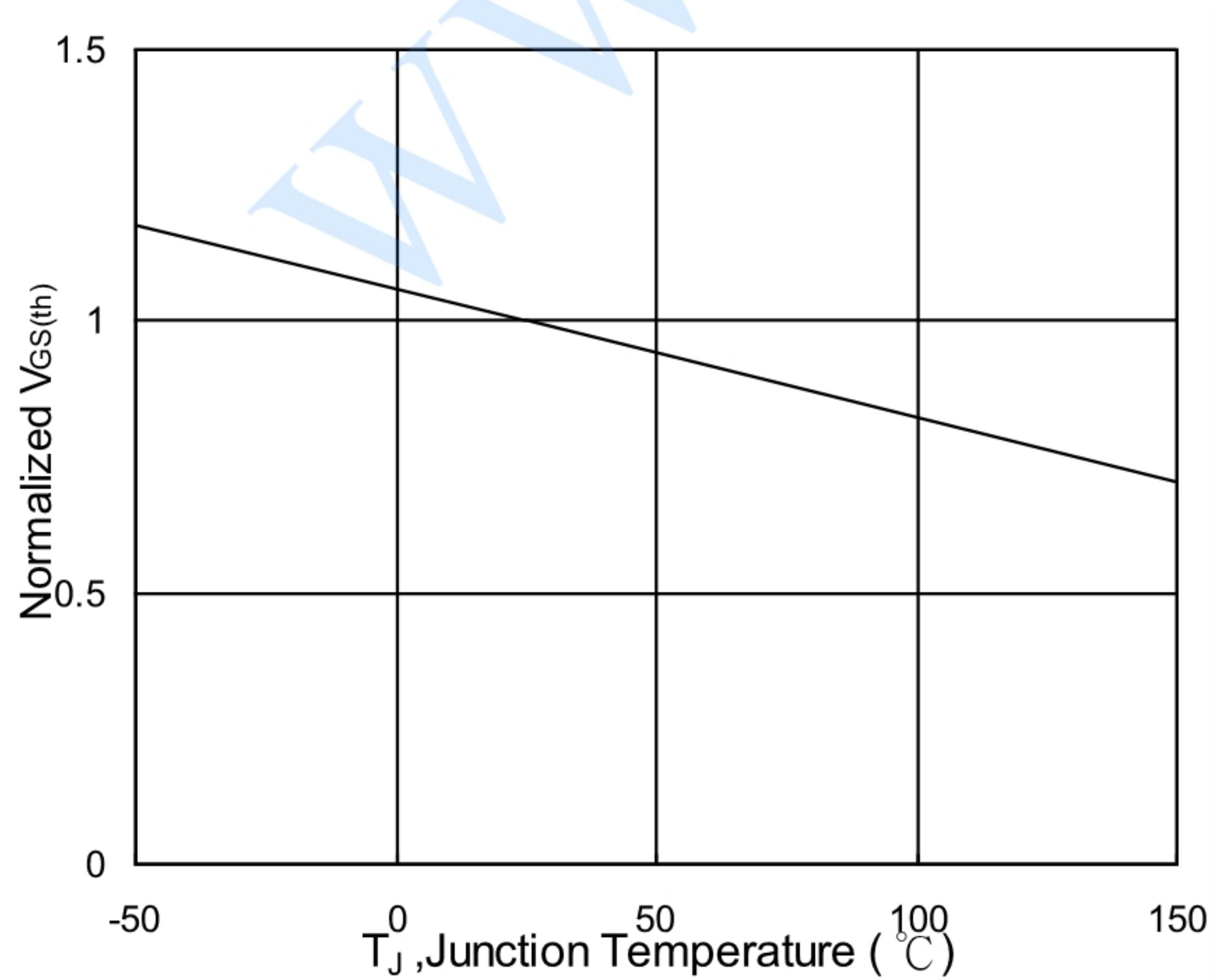
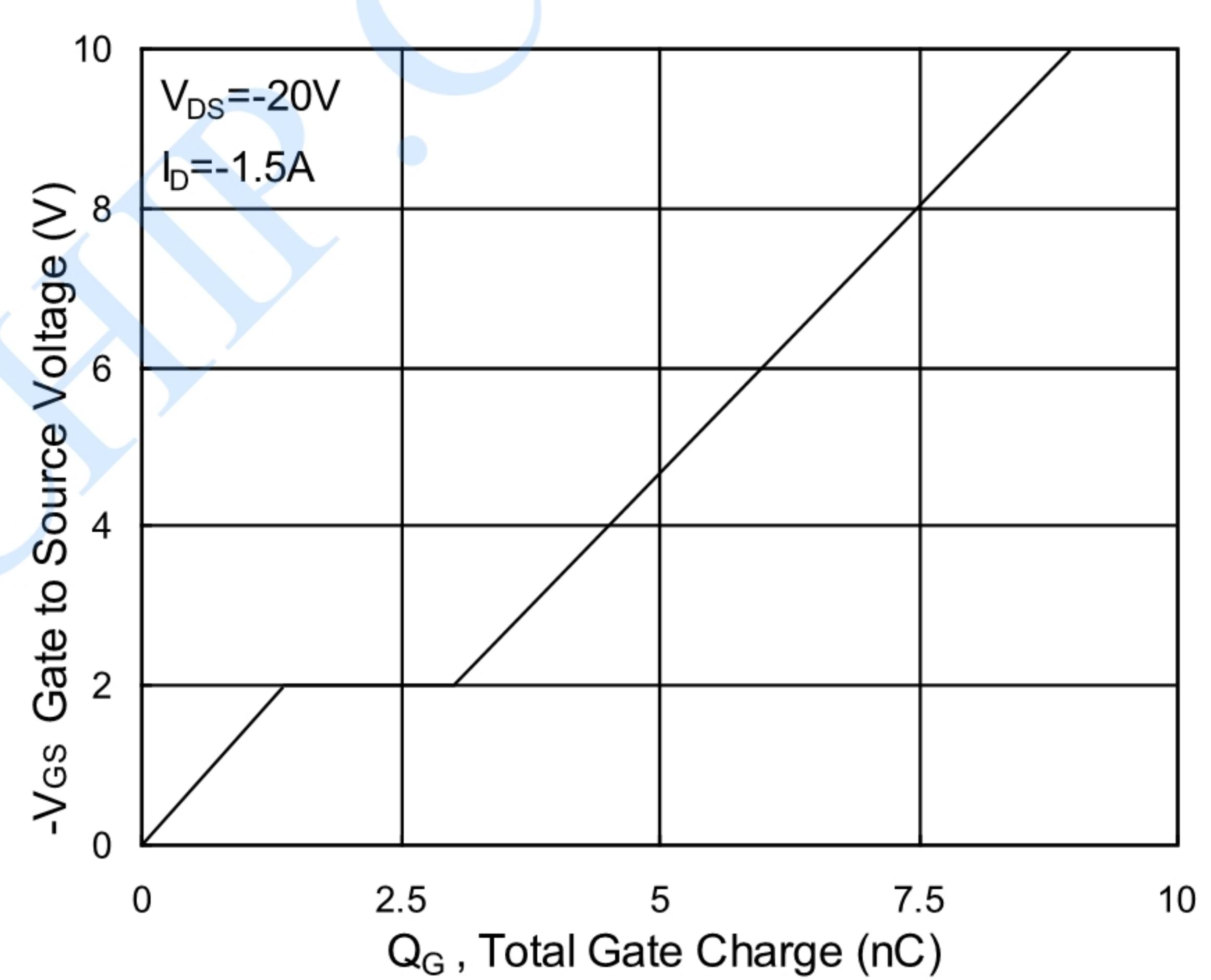
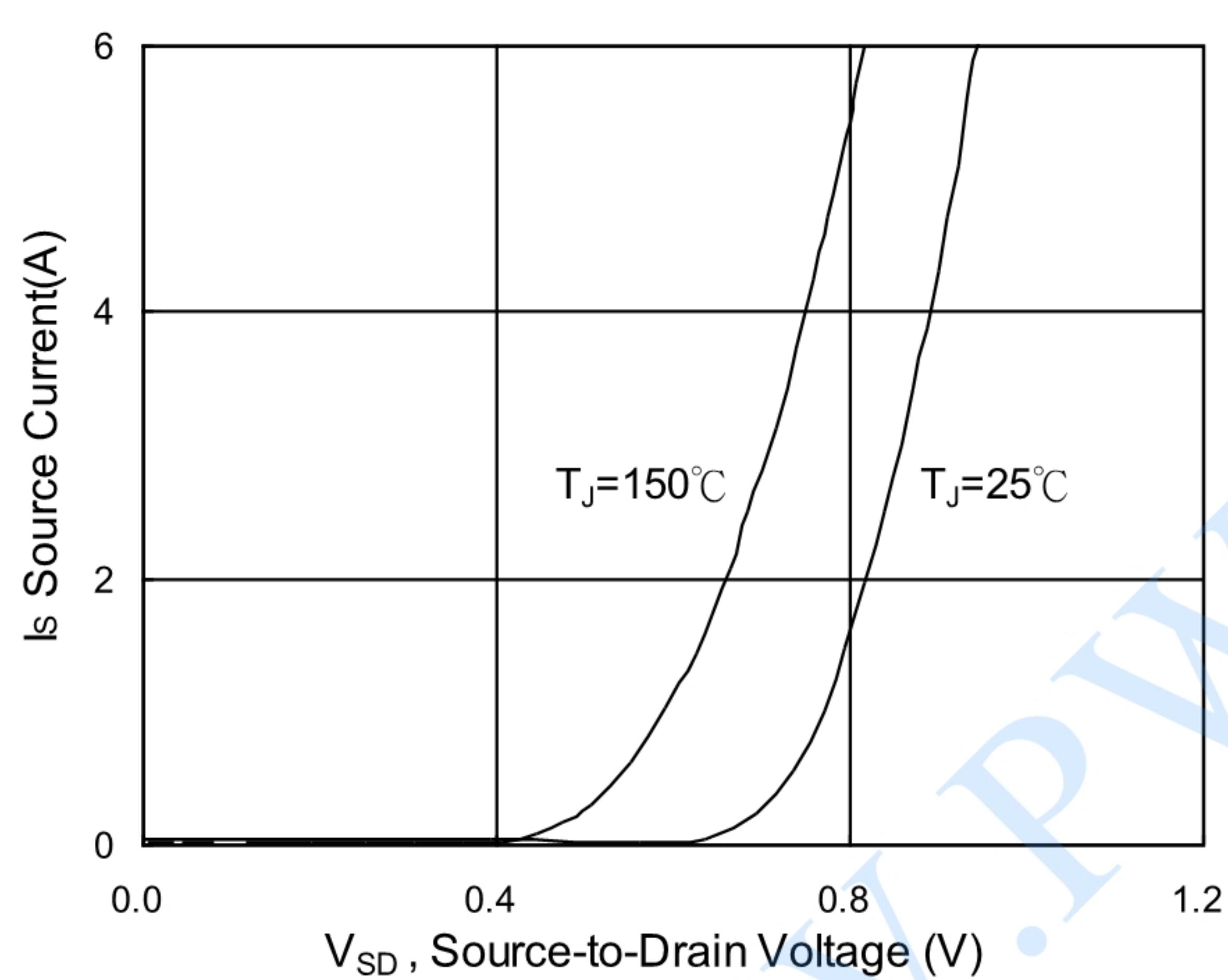
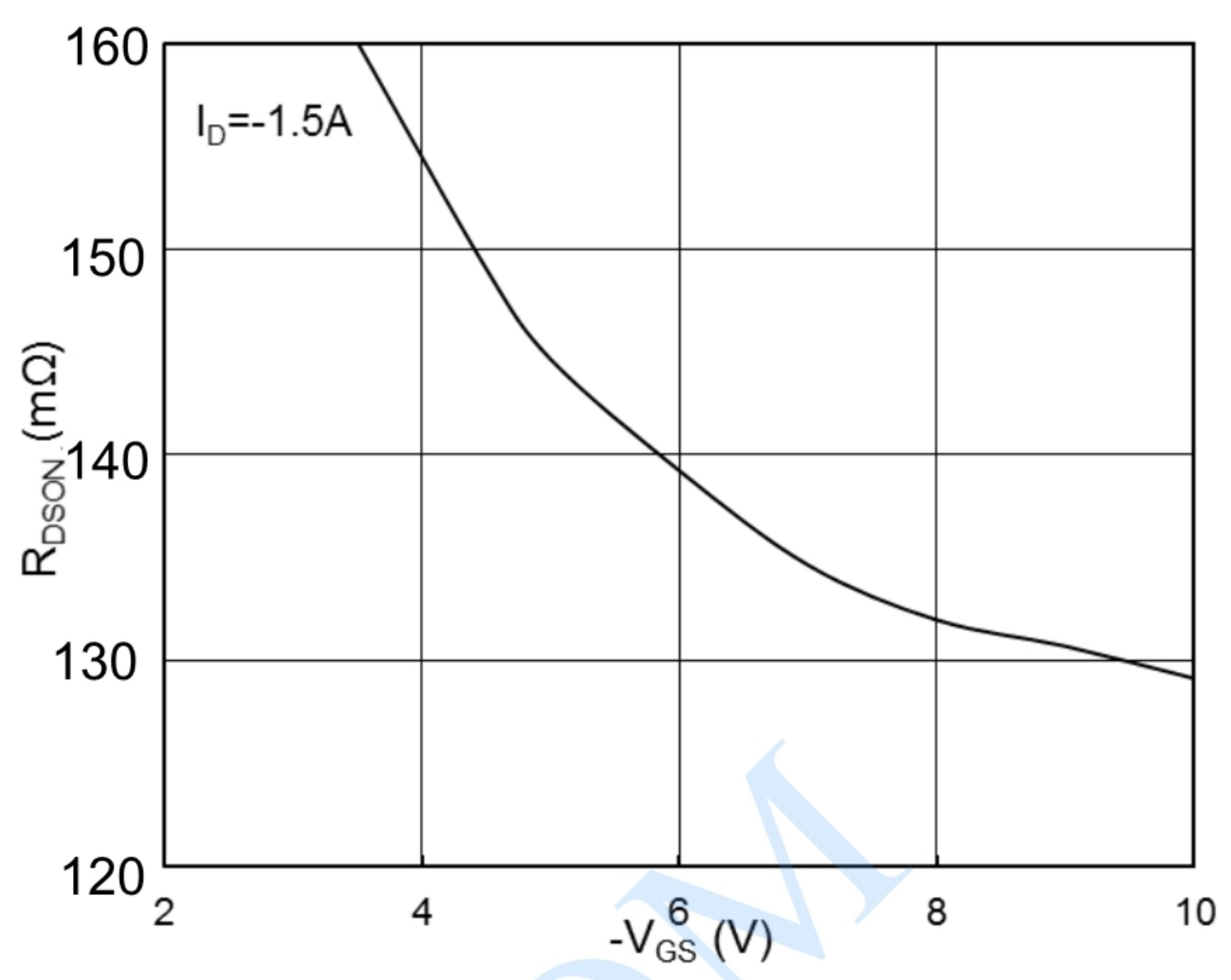
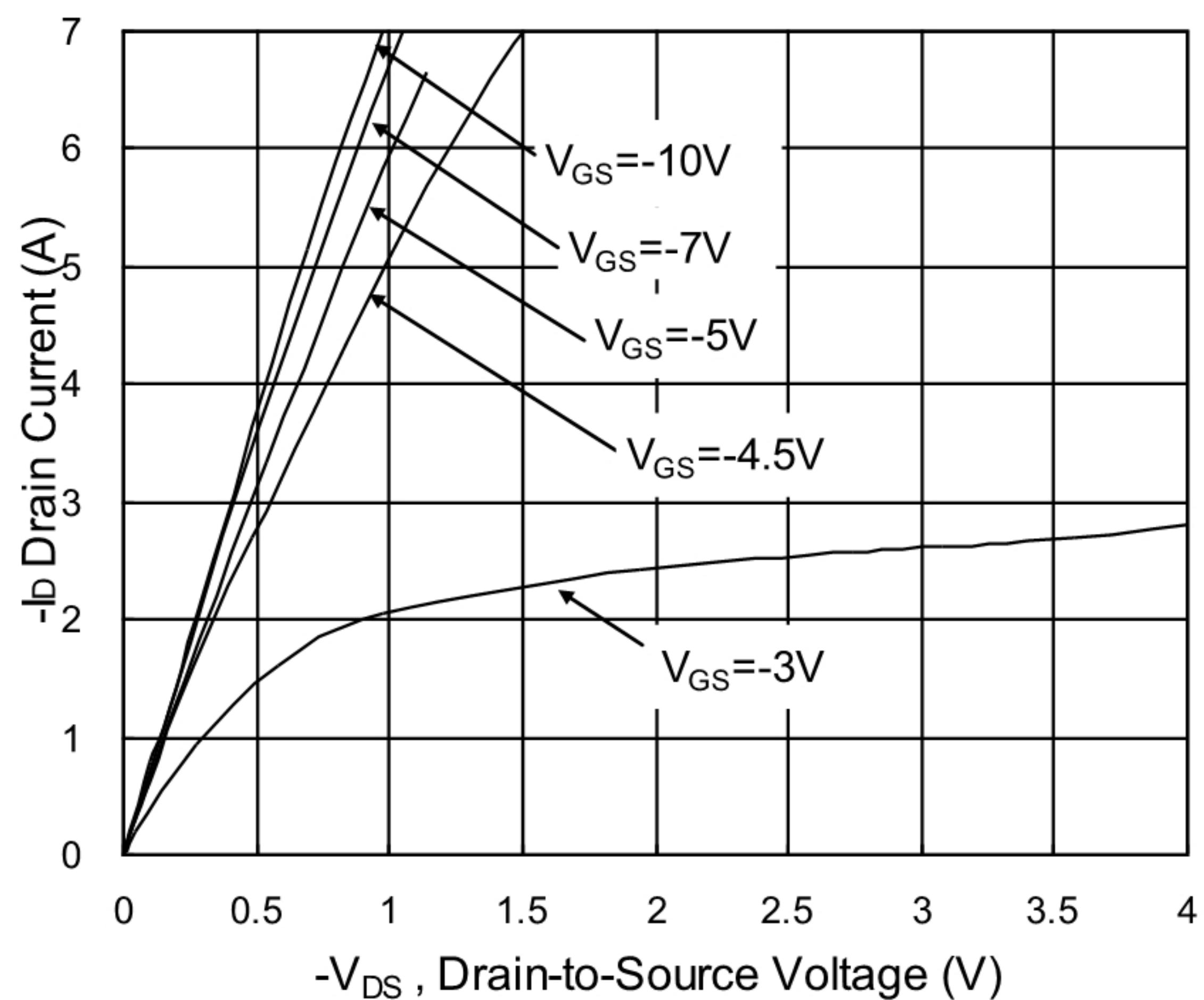
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	VGS=0V , ID=-250uA	-60			V
△BV <sub>DSS</sub> /△T <sub>J</sub>	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , Ib=-1mA		-0.021		V/°C
R <sub>DSON</sub>	Static Drain-Source On-Resistance (NOTE2)	VGS=-10V , ID=-1.5A		130	185	mΩ
		VGS=-4.5V , ID=-1A		158	200	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	VGS=V <sub>DS</sub> , ID=-250uA	-1.0		-2.5	V
△V <sub>GS(th)</sub>	V <sub>GS(th)</sub> Temperature Coefficient			4.08		mV/°C
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA
		V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =-5V , ID=-1.5A		5.9		S
Q <sub>g</sub>	Total Gate Charge (-4.5V)	V <sub>DS</sub> =-20V , V <sub>GS</sub> =-4.5V , Ib=-1.5A		4.6		nC
Q <sub>gs</sub>	Gate-Source Charge			1.4		nC
Q <sub>gd</sub>	Gate-Drain Charge			1.62		nC
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> =-15V , V <sub>GS</sub> =-10V , RG=3.3Ω, ID=-1A		17.4		ns
T <sub>r</sub>	Rise Time			5.4		ns
T <sub>d(off)</sub>	Turn-Off Delay Time			37.2		ns
T <sub>f</sub>	Fall Time			2.4		ns
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		531		pF
C <sub>oss</sub>	Output Capacitance			59		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			38		pF
I <sub>s</sub>	Continuous Source Current(NOTE1, 3)	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-1.7	A
I <sub>SM</sub>	Pulsed Source Current(NOTE2, 3)				-7	A
V <sub>SD</sub>	Diode Forward Voltage (NOTE2)	V <sub>GS</sub> =0V , Is=-1A , T <sub>J</sub> =25°C			-1.2	V

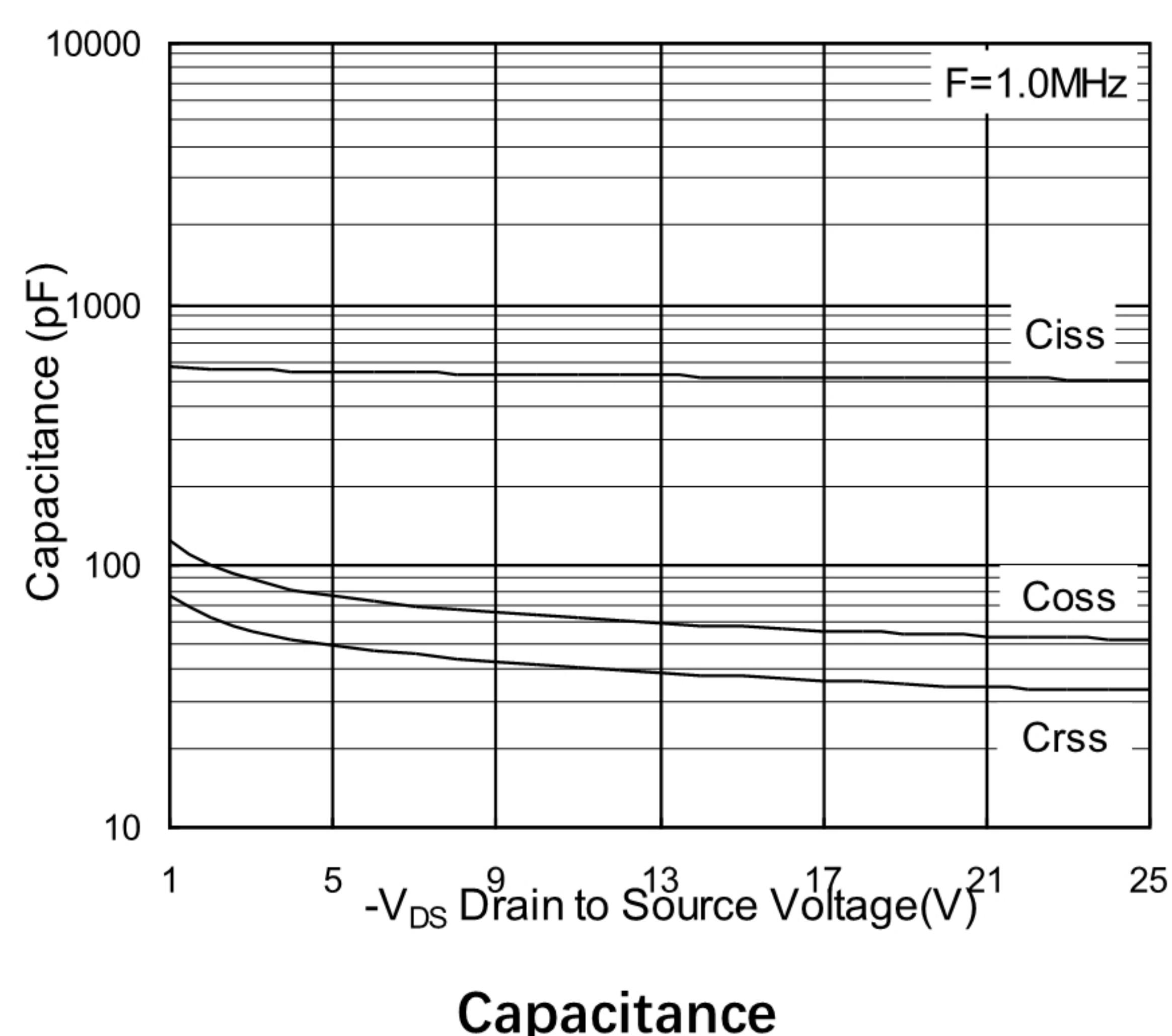
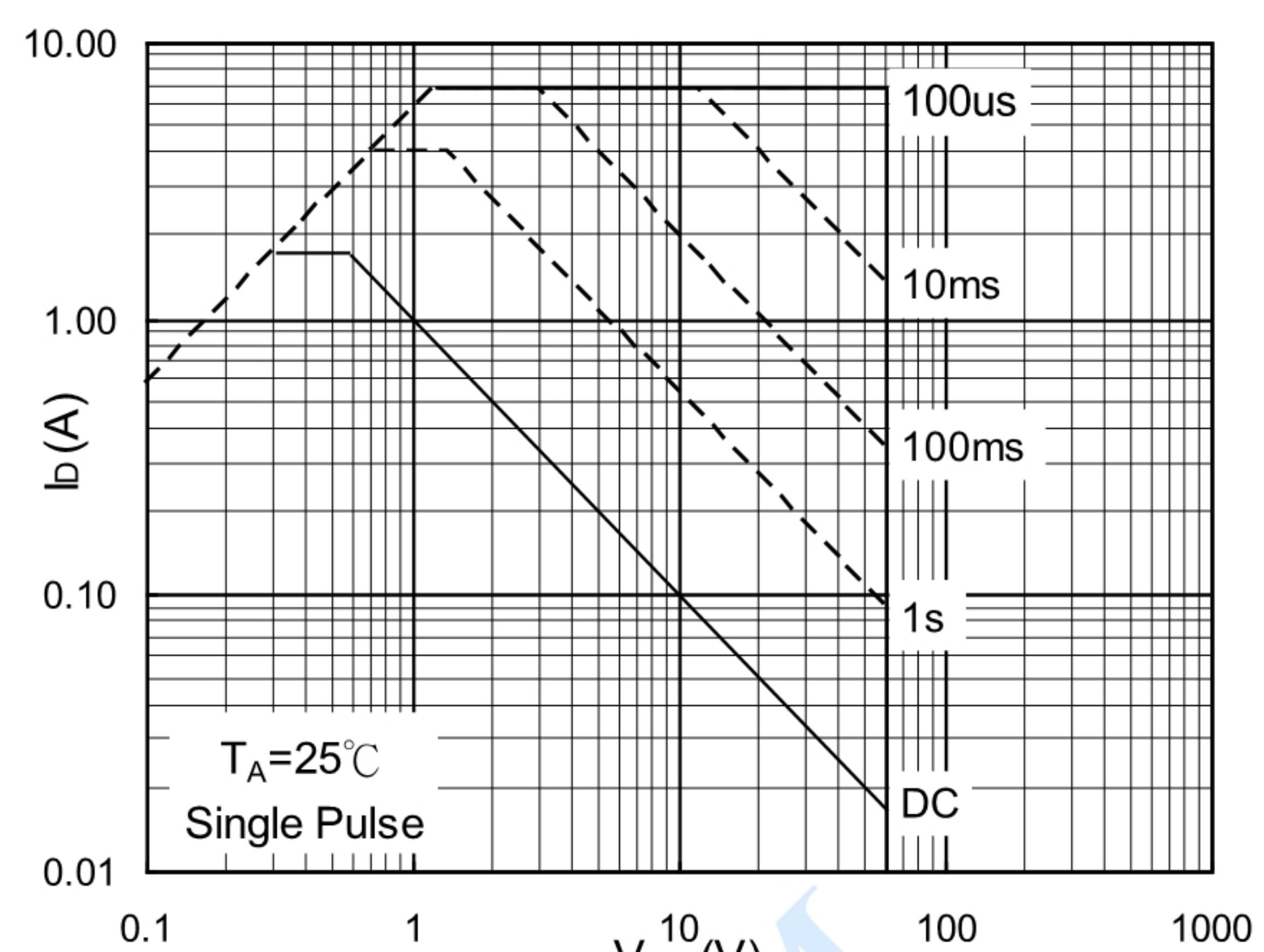
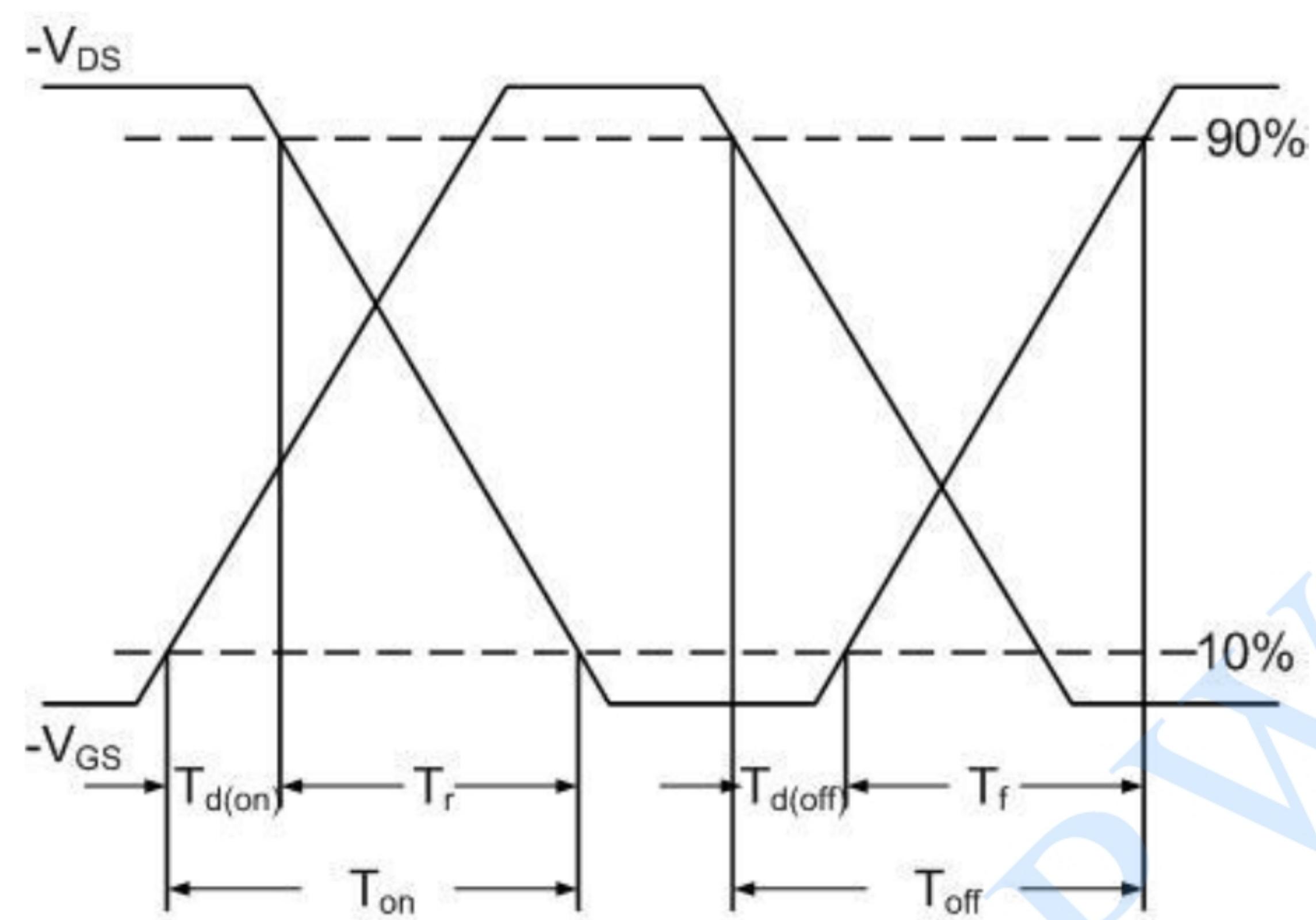
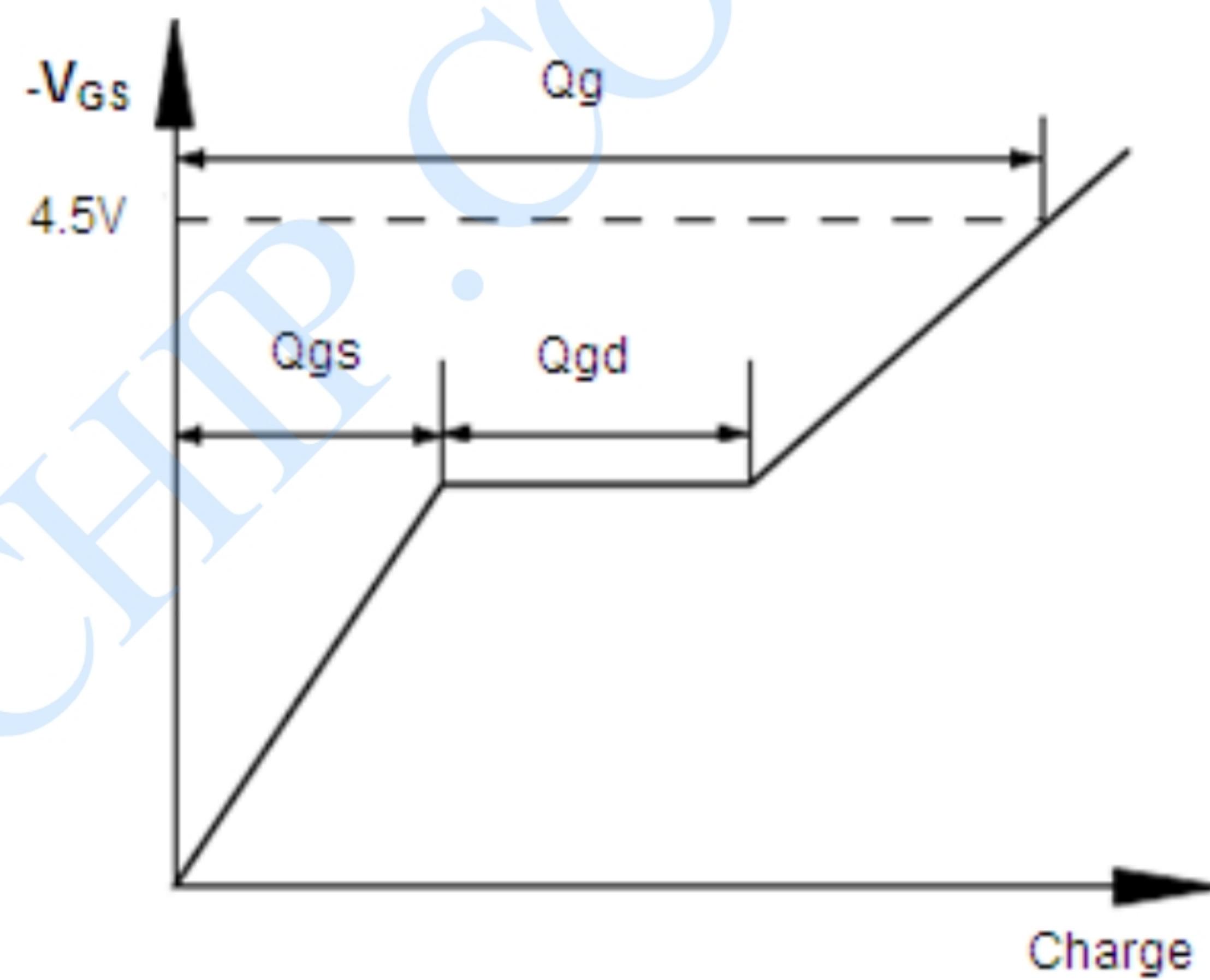
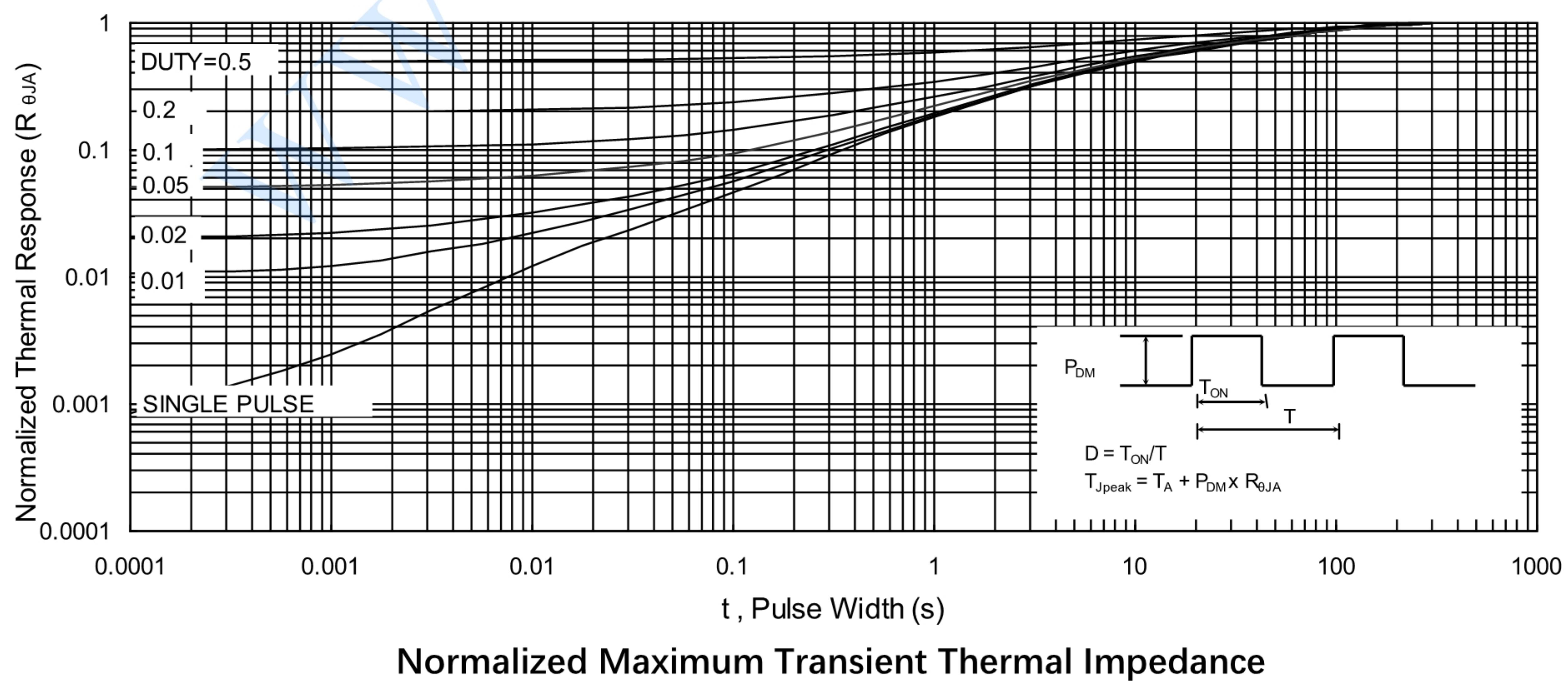
Note 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

Note 2.The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%

Note 3.The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications , should be limited by total power dissipation

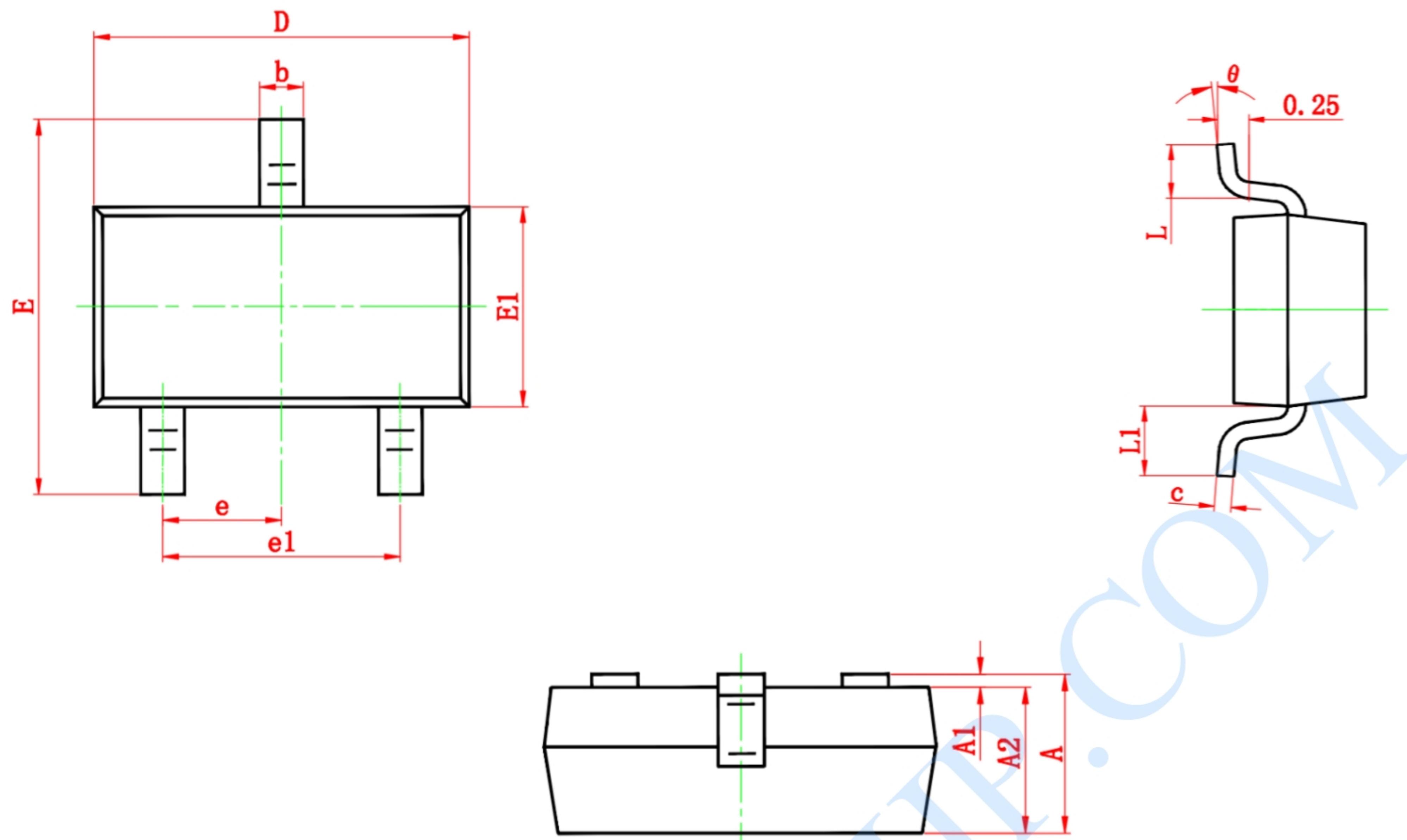
## Thermal Characteristics




**Capacitance**

**Safe Operating Area**

**Switching time waveform**

**Gate Charge waveform**

**Normalized Maximum Transient Thermal Impedance**

## PACKAGE DESCRIPTION

SOT23-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	2.250	2.550	0.089	0.100
E1	1.200	1.400	0.047	0.055
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.300	0.500	0.012	0.020
L1	0.550 REF.		0.022 REF.	
θ	0°	8°	0°	8°

## Notes

1. All dimensions are in millimeters.
2. Tolerance  $\pm 0.10\text{mm}$  (4 mil) unless otherwise specified
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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